

# F9540NS-VB Datasheet P-Channel 100 V (D-S) MOSFET

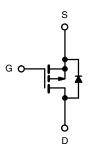
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
- 100	0.040 at $V_{GS} = -10 \text{ V}$	- 37	54 nC		
- 100	$0.050$ at $V_{GS} = -4.5 \text{ V}$	- 32	34 110		

#### **FEATURES**

• Trench Power MOSFET







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (TA =	= 25 °C, unless othe	rwise noted)			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 100	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		- 37		
Outil 2000	T <sub>C</sub> = 70 °C	1 , [	- 29.5		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>b</sup>	T <sub>A</sub> = 25 °C	l <sub>D</sub>	- 10 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	- 8.2 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	- 150	7	
Continuous Course Courset (Diede Conduction)	T <sub>C</sub> = 25 °C	,	- 50 <sup>a</sup>		
Continuous Source Current (Diode Conduction)	T <sub>A</sub> = 25 °C	- I <sub>S</sub> -	- 6.75 <sup>b, c</sup>		
Avalanche Current  Single Pulse Avalanche Energy  L = 0.1 mH		I <sub>AS</sub>	- 35		
		E <sub>AS</sub>	61	mJ	
	T <sub>C</sub> = 25 °C		113.6		
Maximum Davida Dissipation	T <sub>C</sub> = 70 °C		72.7		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	6.9 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C	<b>1</b>	4.4 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Limit	Unit	
Junction-to-Ambient	PCB Mount (TO-263) <sup>c</sup>	R <sub>thJA</sub>	40	°C/W	
Junction-to-Case (Drain)		R <sub>thJC</sub>	2.1	C/VV	

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

服务热线:400-655-8788

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					L	1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 100			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		- 109			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = - 250 μA		5.9		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Walkana Busin Oamani		V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V			- 1		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$	- 40			Α	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 9.2 A		0.040			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 7.7 A		0.050		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 9.2 A		38		S	
Dynamic <sup>b</sup>	•			•		•	
Input Capacitance	C <sub>iss</sub>			3800			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		185		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			135		1	
	Q <sub>g</sub>	V <sub>DS</sub> = -50 V, V <sub>GS</sub> = -10 V, I <sub>D</sub> = -9.2 A		106	160	nC	
Total Gate Charge				54	81		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -9.2 \text{ A}$		14			
Gate-Drain Charge	$Q_{gd}$			26			
Gate Resistance	$R_g$	f = 1 MHz		4		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			15	25		
Rise Time	t <sub>r</sub>	$V_{DD} = -50 \text{ V}, R_{L} = 6.5 \Omega$		20	30	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -7.7 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		110	165		
Fall Time	t <sub>f</sub>			100	150		
Turn-On Delay Time	t <sub>d(on)</sub>			42	65		
Rise Time	t <sub>r</sub>	$V_{DD} = -50 \text{ V}, R_{L} = 6.5 \Omega$		160	240	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 7.7 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		100	150	ns	
Fall Time	t <sub>f</sub>			100	150		
<b>Drain-Source Body Diode Characteristic</b>	s			1			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 50	۸	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 40	A	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 7.7 A		- 0.8	- 1.2	٧	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			60	90	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = - 7.7 A, dl/dt = 100 A/μs, T <sub>.I</sub> = 25 °C		150	225	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$1_{1F} = -7.7 \text{ A}, \text{ ui/ut} = 100 \text{ A/}\mu\text{s}, 1_{J} = 25 ^{\circ}\text{C}$		46			
Reverse Recovery Rise Time	t <sub>b</sub>	<b>-</b>		14		ns	

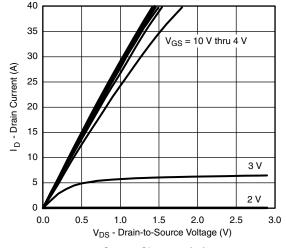
#### Notes

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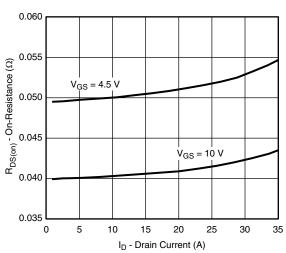
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

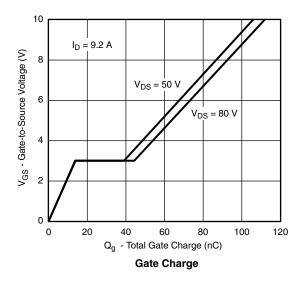


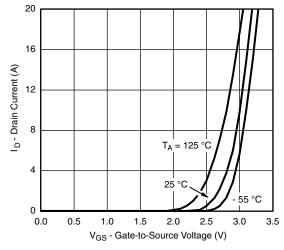


#### **Output Characteristics**

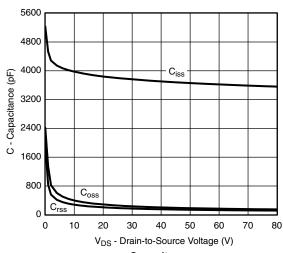


On-Resistance vs. Drain Current and Gate Voltage

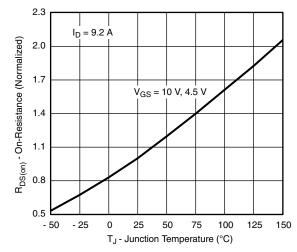




**Transfer Characteristics** 

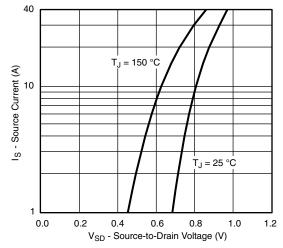


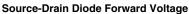
Capacitance

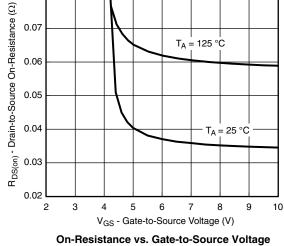


On-Resistance vs. Junction Temperature

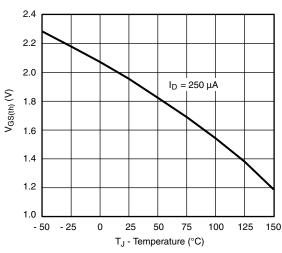




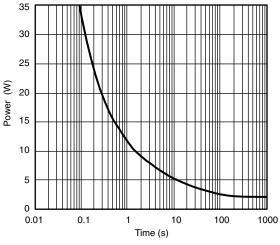




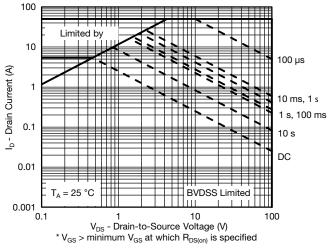
0.08



**Threshold Voltage** 

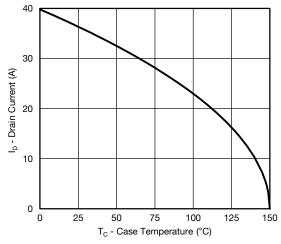


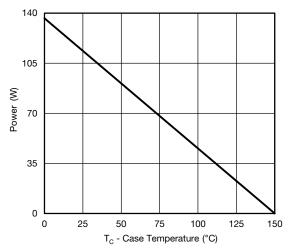
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

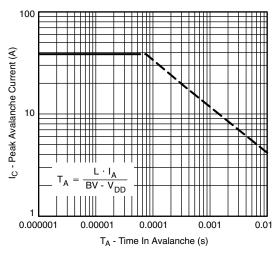






Single Pulse Power, Junction-to-Ambient

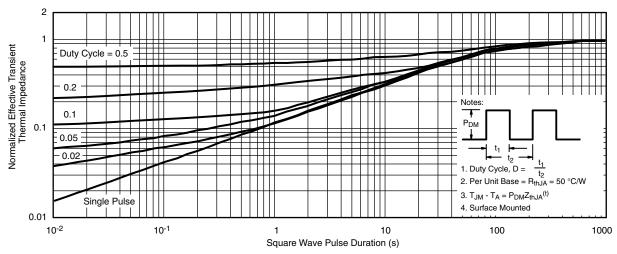




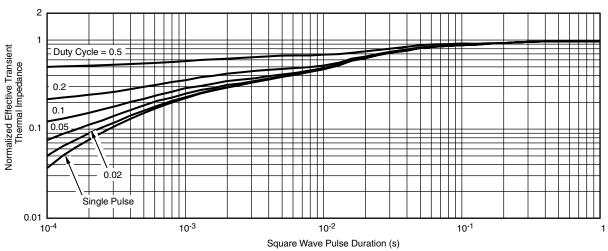
**Single Pulse Avalance Capability** 

 $<sup>^{\</sup>star}$  The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



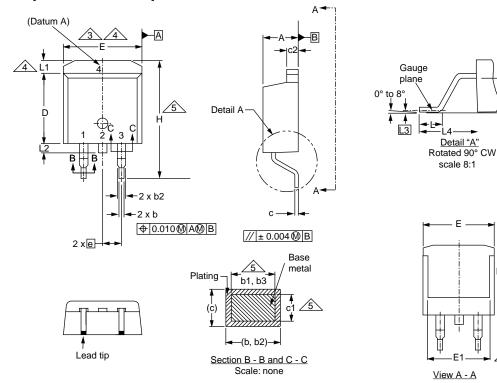
Normalized Thermal Transient Impedance, Junction-to-Case



Seating plane

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#### **TO-263AB (HIGH VOLTAGE)**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
Е	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54 BSC		0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	ı	1.65	1	0.066
L2	ı	1.78	1	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08

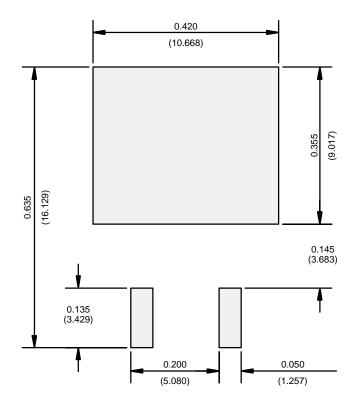
DWG: 5970

#### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



# RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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